


Issue Classification 	Application/Control No. 10/615,050	Applicant(s)/Patent under Reexamination EILERT, SEAN E.
	Examiner Hiep T. Nguyen	Art Unit 2187

ISSUE CLASSIFICATION											
ORIGINAL				INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS		CLAIMED				NON-CLAIMED			
711		220		G 0 6 F 12 02							
CROSS REFERENCES											
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
711	219										
365	230.01										
				<i>Hiep T. Nguyen</i> HIEP T. NGUYEN PRIMARY EXAMINER 2/2/06 (Date)				Total Claims Allowed: 43			
(Assistant Examiner) (Date)				(Primary Examiner)				O.G. Print Claim(s) 1			
(Legal Instruments Examiner) (Date)								O.G. Print Fig. 3			

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant												<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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